

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
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*	B	US-2003/0185309	10-2003	Pautler et al.	375/257
*	C	US-2003/0053571	03-2003	Belotserkovsky et al.	375/350
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**NON-PATENT DOCUMENTS**

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